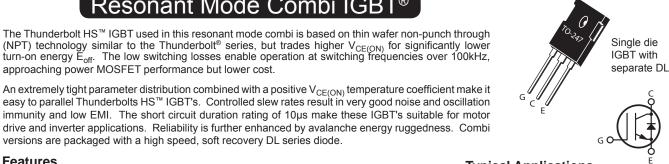


APT50GS60BRDL(G)

600V, 50A, V_{CE(ON)} = 2.8V Typical *G Denotes RoHS Compliant, Pb Free Terminal Finish.

Resonant Mode Combi IGBT®



approaching power MOSFET performance but lower cost. An extremely tight parameter distribution combined with a positive V_{CE(ON)} temperature coefficient make it

easy to parallel Thunderbolts HS™ IGBT's. Controlled slew rates result in very good noise and oscillation immunity and low EMI. The short circuit duration rating of 10µs make these IGBT's suitable for motor drive and inverter applications. Reliability is further enhanced by avalanche energy ruggedness. Combi versions are packaged with a high speed, soft recovery DL series diode.

Features

- Fast Switching with low EMI
- Very Low E_{OFF} for Maximum Efficiency Easy paralleling
- · Short circuit rated
- · Low Gate Charge
- RoHS Compliant 🥖

- Tight parameter distribution
- Low Forward Diode Voltage (VF)
- Ultrasoft Recovery Diode

Typical Applications

- ZVS Phase Shifted Bridge
- Resonant Mode Switching
- Phase Shifted Bridge
- Welding
- Induction heating
- High Frequency SMPS

Absolute	Absolute Maximum Ratings							
Symbol	Parameter	Rating	Unit					
I _{C1}	Continuous Collector Current $T_C = @ 25^{\circ}C$	93						
I _{C2}	Continuous Collector Current T _C = @ 100°C	50	A					
I _{CM}	Pulsed Collector Current ①	195						
V_{GE}	Gate-Emitter Voltage	±30V	V					
SSOA	Switching Safe Operating Area	195						
t _{sc}	Short Circut Withstand Time ^③	10	μs					

Thermal and Mechanical Characteristics

Symbol	Parameter		Min	Тур	Max	Unit
P _D	Total Power Dissipation T _C = @ 25°C		-	-	415	W
R _{θJC}	Junction to Case Thermal Resistance	IGBT	-	-	0.30	
'`θJC		Diode			0.63	°C/W
R _{0CS}	Case to Sink Thermal Resistance, Flat Greased Surface		-	0.11	-	
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55	-	150	°C
Τ _L	Soldering Temperature for 10 Seconds (1.6mm from case)		-	-	300	
W _T	Package Weight		-	0.22	-	oz
			-	5.9	-	g
т	Mounting Torque (TO 247) 6 22 M2 Serous		-	- - 0.11 - 0.22	10	in∙lbf
Torque	Mounting Torque (TO-247), 6-32 M3 Screw		-	-	1.1	N∙m

CAUTION: These Devices are Sensitive to Electrostatic Discharge. Proper Handling Procedures Should be Followed.

Static Characteristics

$T_J = 25^{\circ}C$ unless otherwise specified

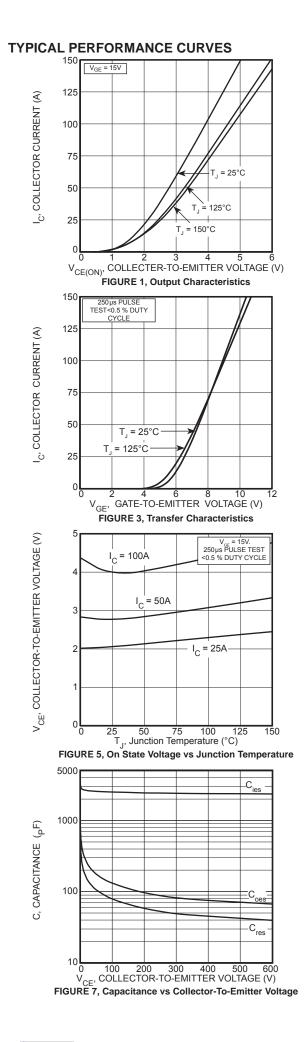
APT50GS60BRDL(G)

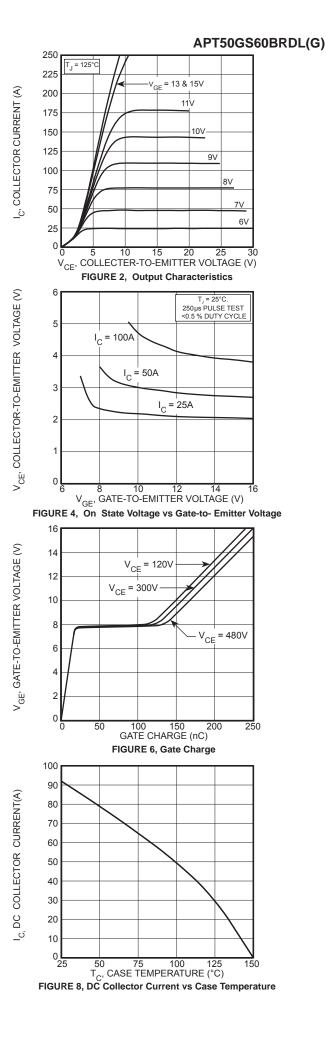
Symbol	Parameter	Test Conditions		Min	Тур	Max	Unit
V _{BR(CES)}	Collector-Emitter Breakdown Voltage	V _{GE} = 0V, I _C = 250µA		600	-	-	V
$\Delta V_{BR(CES)} / \Delta T_J$	Breakdown Voltage Temperature Coeff	Reference to 25°C, I _C = 250µA		-	0.60	-	V/°C
V	Collector-Emitter On Voltage ^④	V _{GE} = 15V	T _J = 25°C	-	2.8	3.15	
V _{CE(ON)}		$I_{\rm C} = 50$ A	T _J = 125°C	-	3.25	-	V
V _{GE(th)}	Gate-Emitter Threshold Voltage	$V_{GE} = V_{CE}, I_C = 1mA$		3	4	5	
$\Delta V_{GE(th)} / \Delta T_J$	Threshold Voltage Temp Coeff			-	6.7	-	mV/°C
1	Zere Cete Veltere Cellecter Current	t $V_{CE} = 600V,$ $V_{GE} = 0V$	T _J = 25°C	-	-	50	
CES	Zero Gate Voltage Collector Current	V _{GE} = 0V	T _J = 125°C	-	-	1000	μA
I _{GES}	Gate-Emitter Leakage Current	$V_{GE} = \pm 20V$		-	-	±100	nA

Dynamic Characteristics

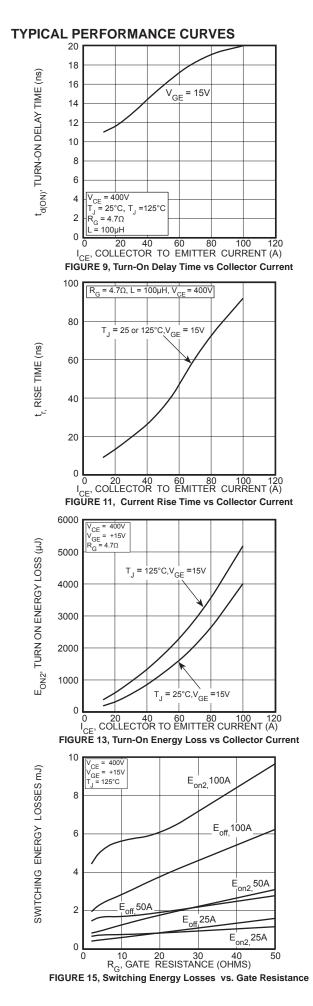
T_J = 25°C unless otherwise specified

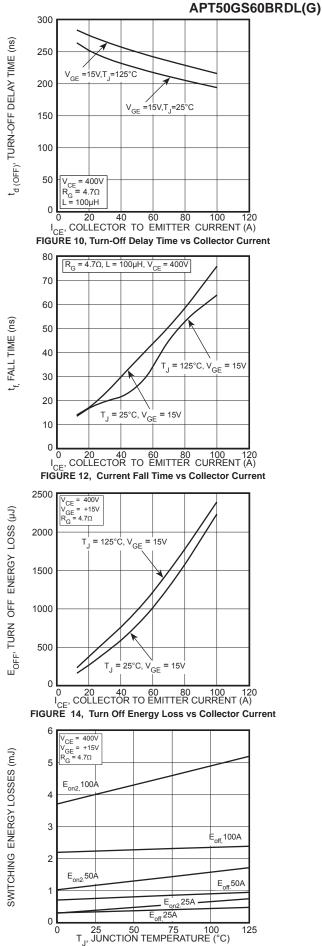
Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
9 _{fs}	Forward Transconductance	V _{CE} = 50V, I _C = 50A	-	31	-	S
C _{ies}	Input Capacitance		-	2635	-	
C _{oes}	Output Capacitance	V _{GE} = 0V, V _{CE} = 25V f = 1MHz	-	240	-	
C _{res}	Reverse Transfer Capacitance		-	145	-	pF
C _{o(cr)}	Reverse Transfer Capacitance Charge Related ⁽⁵⁾	V _{GE} = 0V	-	115	-	
C _{o(er)}	Reverse Transfer Capacitance Current Related ⁶	$V_{GE} = 0V$ $V_{CE} = 0 \text{ to } 400V$		85		
Qg	Total Gate Charge		-	235	-	
Q _{ge}	Gate-Emitter Charge	$V_{GE} = 0 \text{ to } 15V$ $I_C = 50A, V_{CE} = 300V$	-	18	-	nC
G _{gc}	Gate-Collector Charge	$_{\rm C} = 50$ A, $v_{\rm CE} = 500$ V	-	100	-	
t _{d(on)}	Turn-On Delay Time		-	16	-	
t _r	Rise Time	Inductive Switching IGBT and	-	33	-	
t _{d(off)}	Turn-Off Delay Time	Diode:	-	225	-	ns
t _f	Fall Time	T = 25°C, V _{CC} = 400V,	-	37	-	
E _{on1}	Turn-On Switching Energy [®]	$I_{\rm C} = 50A$	-	TBD	-	
E _{on2}	Turn-On Switching Energy ⁽⁹⁾	$I_{c} = 50A$ $R_{G} = 4.7\Omega^{(2)}, V_{GG} = 15V$	-	1.2	-	mJ
E _{off}	Turn-Off Switching Energy 10		-	0.755	-	
t _{d(on)}	Turn-On Delay Time		-	33	-	
t _r	Rise Time	Inductive Switching IGBT and	-	33	-	
t _{d(off)}	Turn-Off Delay Time	Diode:	-	250	-	ns
t _f	Fall Time	T _J = 125°C, V _{CC} = 400V,	-	23	-	
E _{on1}	Turn-On Switching Energy [®]	$T_{J} = 125^{\circ}C, V_{CC} = 400V,$ $I_{C} = 50A$ $R_{G} = 4.7\Omega^{7}, V_{GG} = 15V$	-	TBD	-	
E _{on2}	Turn-On Switching Energy ⁽⁹⁾	$R_{G} = 4.7 \Omega^{-3}, V_{GG} = 15V$	-	1.7	-	mJ
E _{off}	Turn-Off Switching Energy 10		-	0.950	-	





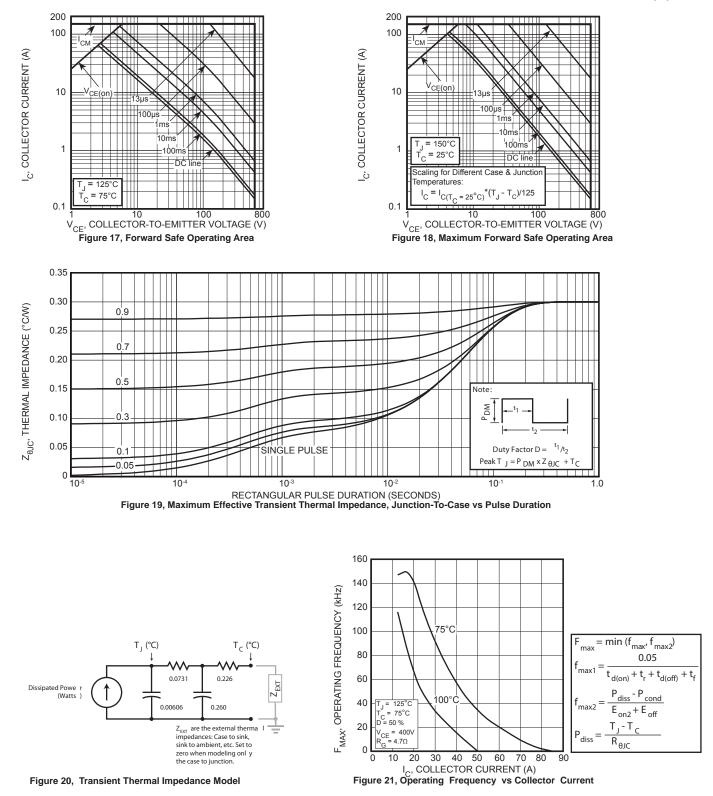
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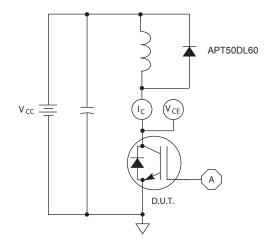


TYPICAL PERFORMANCE CURVES

APT50GS60BRDL(G)



APT50GS60BRDL(G)



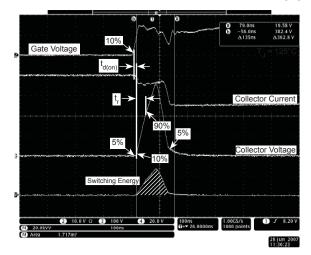


Figure 23, Turn-on Switching Waveforms and Definitions

Figure 22, Inductive Switching Test Circuit

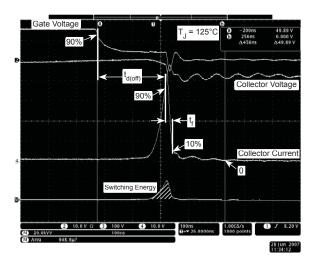


Figure 24, Turn-off Switching Waveforms and Definitions

FOOT NOTE:

- (1) Repetitive Rating: Pulse width and case temperature limited by maximum junction temperature.
- (3) Short circuit time: $V_{GE} = 15V$, $V_{CC} \le 600V$, $T_{J} \le 150^{\circ}C$
- (4) Pulse test: Pulse width < 380µs, duty cycle < 2%
- (5) C_{o(cr)} is defined as a fixed capacitance with the same stored charge as C_{oes} with V_{CE} = 67% of V_{(BR)CES}.

 $\tilde{6}$ $C_{o(er)}^{(o(f))}$ is defined as a fixed capacitance with the same stored energy as $C_{oes}^{(o(er))}$ with $V_{CE}^{(o(er))} = 67\%$ of $V_{(BR)CES}^{(o(er))}$. To calculate $C_{o(er)}$ for any value of \mathbb{Q}_{CE} less than V_{(BR)CES}, use this equation: C_{o(er)} = 5.57E-8/V_{DS}² + 7.15E-8/V_{DS} + 2.75E-10. 7 R_G is external gate resistance, not including internal gate resistance or gate driver impedance (MIC4452).

- (8) E_{an1} is the inductive turn-on energy of the IGBT only, without the effect of a commutating diode reverse recovery current adding to the IGBT turn-on switching loss. It is measured by clamping the inductance with a Silicon Carbide Schottky diode.
- 9 E_{on2} is the inductive turn-on energy that includes a commutating diode reverse recovery current in the IGBT turn-on energy.
- 0 Eoff is the clamped inductive turn-off energy measured in accordance with JEDEC standard JESD24-1.
 - Microsemi reserves the right to change, without notice, the specifications and information contained herein.

ULTRAFAST SOFT RECOVERY ANTI-PARALLEL DIODE

MAXIMUM RATINGS

All Ratings: $T_{C} = 25^{\circ}C$ unless otherwise specified.

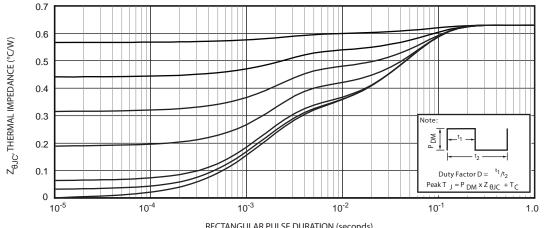
Symbol	Characteristic / Test Conditions	APT50GS60BRDL(G)		UNIT	
I _F (AV)	Maximum Average Forward Current (T _C = 124°C, Duty Cycle = 0.5)		50		
I _F (RMS)	RMS Forward Current (Square wave, 50% duty)		150		Amps
I _{FSM}	Non-Repetitive Forward Surge Current $(T_J = 45^{\circ}C, 8.3ms)$		320		

STATIC ELECTRICAL CHARACTERISTICS

Symbol	Characteristic / Test Conditions		MIN	ТҮР	MAX	UNIT
		I _F = 50A		1.25	1.6	
V _F	Forward Voltage	I _F = 100A		2.0		Volts
		Ι _F = 50A, Τ _J = 125°C		1.25		

DYNAMIC CHARACTERISTICS

Symbol	Characteristic	Test Conditions	MIN	TYP	MAX	UNIT
t _{rr}	Reverse Recovery Time $I_F = 1A$, $di_F/dt =$	= -100A/µs, V _R = 30V, T _J = 25°C	-	52		
t _{rr}	Reverse Recovery Time	I _F = 50A, di _F /dt = -200A/μs V _R = 400V, T _C = 25°C	-	399		ns
Q _{rr}	Reverse Recovery Charge		-	1498		nC
I _{RRM}	Maximum Reverse Recovery Current		-	9	-	Amps
t _{rr}	Reverse Recovery Time	I _F =50A, di _F /dt = -200A/µs V _R = 400V, T _C = 125°C	-	649		ns
Q _{rr}	Reverse Recovery Charge		-	3734		nC
I _{RRM}	Maximum Reverse Recovery Current		-	13	-	Amps
t _{rr}	Reverse Recovery Time		-	284		ns
Q _{rr}	Reverse Recovery Charge	I _F = 50A, di _F /dt = -1000A/µs V _R = 400V, T _C = 125°C	-	5134		nC
I _{RRM}	Maximum Reverse Recovery Current		-	34		Amps





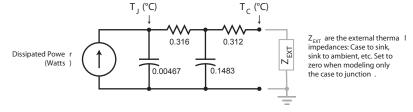
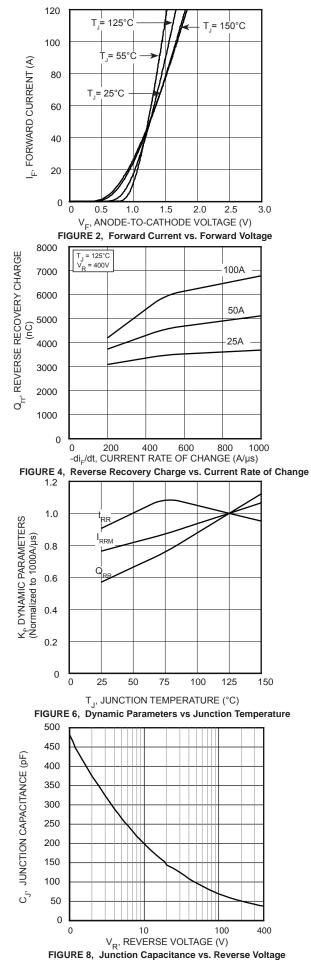


FIGURE 1b, TRANSIENT THERMAL IMPEDANCE MODEL

TYPICAL PERFORMANCE CURVES

APT50GS60BRDL(G)



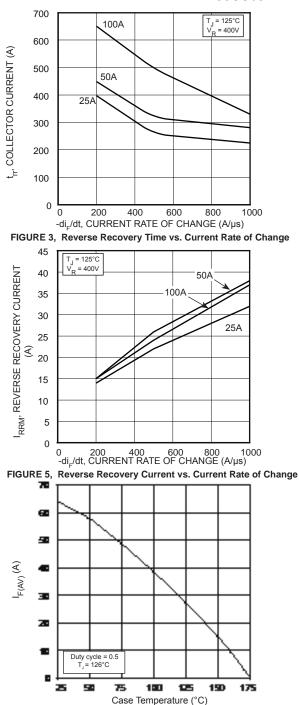
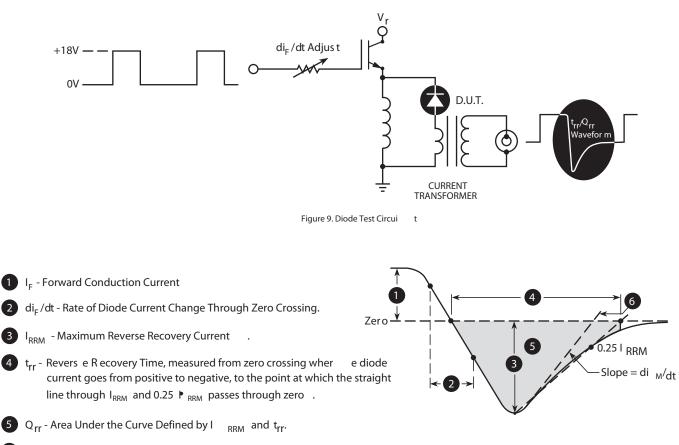


FIGURE 7, Maximum Average Forward Current vs. Case Temperature

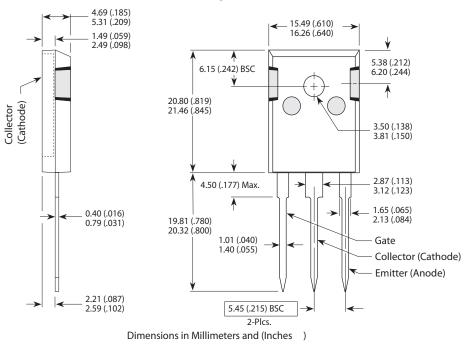




6 di_M/dt - Maximum Rate of Current Increase During the Trailing Portion of t rr.

Figure 10, Diode Reverse Recovery Waveform and Definition

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TO-247 (B) Package Outline